

Search Notes**Application/Control No.**

10/681,305

Examiner

Richard Chan

Applicant(s)/Patent under Reexamination

MAEDA ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	108		
455	109		
455	102		
455	129		
455	114.2		
375	244		
375	298		
375	300		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted Ed Urban with 455 search	4/6/2006	RC
Consulted Quochien Young with 455 class search	4/10/2006	RC